

Notice of References Cited	Application/Control No. 10/621,687		Applicant(s)/Patent Under Reexamination MCFARLAND, WILLIAM J.	
	Examiner SIMON D. NGUYEN		Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0017794	01-2004	Trachewsky, Jason A.	370/338
*	B	US-6,415,001	07-2002	Li et al.	375/259
*	C	US-2004/0029548	02-2004	Li, Junsong	455/307
*	D	US-6,370,360	04-2002	Kunkel, Lars Peter	455/76
*	E	US-6,215,988	04-2001	Matero, Jorma	455/188.1
*	F	US-2005/0239499	10-2005	Oosawa et al.	455/552.1
*	G	US-6,728,517	04-2004	Sugar et al.	455/73
*	H	US-6,151,354	11-2000	Abbey, Duane L.	375/211
*	I	US-6,332,083	12-2001	Shi et al.	455/552.1
*	J	US-6,985,701	01-2006	Yoshida et al.	455/76
*	K	US-2001/0049271	12-2001	Hirtzlin et al.	455/188.1
*	L	US-6,131,022	10-2000	Jacomb-Hood et al.	455/276.1
*	M	US-6,970,681	11-2005	Darabi et al.	455/73

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.